

Notice of References Cited			Application/Control No.	Applicant(s)/Patent Under Reexamination MURAKAMI ET AL.	
			Examiner AMARA ABDI	Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0012406	01-2003	Iwamura, Keiichi	382/100
*	B	US-2003/0123698	07-2003	Murakami, Tomochika	382/100
*	C	US-2003/0009674	01-2003	Pelly et al.	713/176
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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